

Search Notes

Application/Control No.

10/629,543

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2192

SEARCHED

Class	Subclass	Date	Examiner
717	168-173, 174	3/9/2006	CD
717	124	3/9/2006	CD
711	102-104		
700	81		
713	2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search for double patenting WEST - USPATFILE - USPGPUB - US OCR - JPO ABS - EPO ABS - DWPI - IBM TECH	3/9/2006	CD
ACM IEEE	3/9/2006	CD